

**Search Notes**

Application/Control No.

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Examiner

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Applicant(s)/Patent under  
Reexamination

OHASHI, TADASHI

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner
707	100-104.1	2/28/2007	IW
715	500-529	2/28/2007	IW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPUB&USPAT text search - See history search printout		2/28/2007	IW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See search history printout(s), ACM, IEEE, Google	2/28/2007	IW